

AON6411

20V P-Channel MOSFET

General Description

The AON6411 combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{\text{DS(ON)}}$. This device is ideal for load switch and battery protection applications.

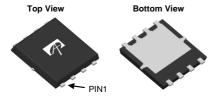
Product Summary

 $\begin{array}{lll} V_{DS} & -20 \\ I_{D} & (at \ V_{GS} \!=\! -10 V) & -85 A \\ R_{DS(ON)} & (at \ V_{GS} \!=\! -10 V) & < 2.1 m \Omega \\ R_{DS(ON)} & (at \ V_{GS} \!=\! -4.5 V) & < 2.5 m \Omega \\ R_{DS(ON)} & (at \ V_{GS} \!=\! -2.5 V) & < 3.6 m \Omega \end{array}$

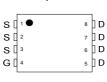
 $\begin{array}{cc} 100\% \text{ UIS Tested} \\ 100\% \text{ } \text{R}_{\text{g}} \text{ Tested} \end{array}$

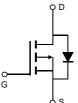












Absolute Maximum Ratings T_A=25℃ unless otherwise noted

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	-20	V	
Gate-Source Voltage		V _{GS}	±12	V	
Continuous Drain	T _C =25℃	I-	-85		
Current ^G	T _C =100℃	I _D	-67	A	
Pulsed Drain Current ^C		I _{DM}	-340		
Continuous Drain Current	T _A =25℃		-47	A	
	T _A =70℃	IDSM	-38	^	
Avalanche Current ^C		I _{AS}	70	A	
Avalanche energy L=0.1mH ^C		E _{AS}	245	mJ	
Power Dissipation ^B	T _C =25℃	P _D	156	W	
	T _C =100℃	' D	62.5	VV	
Power Dissipation ^A	T _A =25℃	P _{DSM}	7.3	W	
	T _A =70℃	DSM	4.7	VV	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	C	

Thermal Characteristics									
Parameter	Symbol	Тур	Max	Units					
Maximum Junction-to-Ambient A	t ≤ 10s	D	14	17	C/W				
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	40	55	€/M				
Maximum Junction-to-Case Steady-St		$R_{\theta JC}$	0.6	0.8	C/W				



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units			
STATIC PARAMETERS									
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =-250μA, V _{GS} =0V		-20			V		
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =-20V, V_{GS} =0V				-1	μΑ		
			T _J =55℃			-5			
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±12V				±100	nA		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS, I_D} = -250 \mu A$		-0.5	-0.85	-1.3	V		
I _{D(ON)}	On state drain current	V _{GS} =-10V, V _{DS} =-5V		-340			Α		
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =-10V, I_{D} =-20A			1.7	2.1	mΩ		
			T _J =125℃		2.45	3			
		V _{GS} =-4.5V, I _D =-20A			2	2.5	mΩ		
		V _{GS} =-2.5V, I _D =-20A			2.8	3.6	mΩ		
g _{FS}	Forward Transconductance	V_{DS} =-5V, I_{D} =-20A			115		S		
V_{SD}	Diode Forward Voltage	I _S =-1A,V _{GS} =0V			-0.57	-1	V		
Is	Maximum Body-Diode Continuous Current ^G					-85	Α		
DYNAMIC	PARAMETERS								
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =-10V, f=1MHz			10290		pF		
C _{oss}	Output Capacitance				1910		pF		
C _{rss}	Reverse Transfer Capacitance				1395		pF		
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz			2.1	4.2	Ω		
SWITCHI	NG PARAMETERS								
Q _g (10V)	Total Gate Charge	V _{GS} =-10V, V _{DS} =-10V, I _D =-20A			235	330	nC		
Q _g (4.5V)	Total Gate Charge				100	140	nC		
Q_{gs}	Gate Source Charge				21		nC		
Q_{gd}	Gate Drain Charge				36		nC		
t _{D(on)}	Turn-On DelayTime				9		ns		
t _r	Turn-On Rise Time	V_{GS} =-10V, V_{DS} =-10V, R_L =0.5 Ω , R_{GEN} =3 Ω			18		ns		
t _{D(off)}	Turn-Off DelayTime				282		ns		
t _f	Turn-Off Fall Time				90		ns		
t _{rr}	Body Diode Reverse Recovery Time	I _F =-20A, dI/dt=500A/μs			48		ns		
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =-20A, dI/dt=500A/µ	μs		178		nC		
A The value of R is measured with the device mounted on 1in ² FR-4 board with 2oz. Copper in a still air environment with T. =25° C. The									

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 150° C may be used if the PCB allows it.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ =150° C. Ratings are based on low frequency and duty cycles to keep initial T_J =25° C.Maximum UIS current limited by test equipment.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

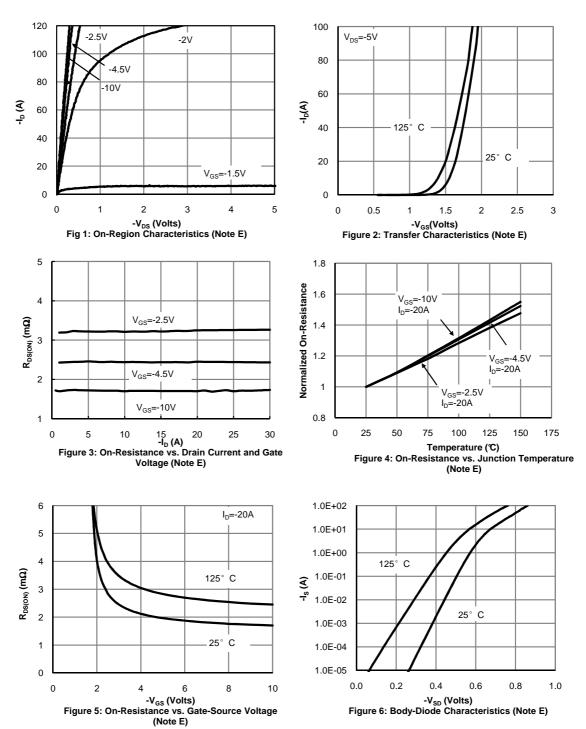
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}=150^{\circ}$ C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

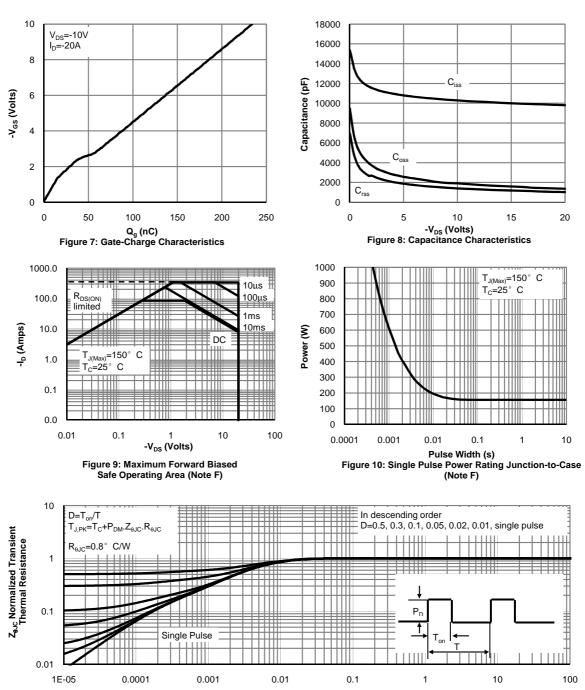


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





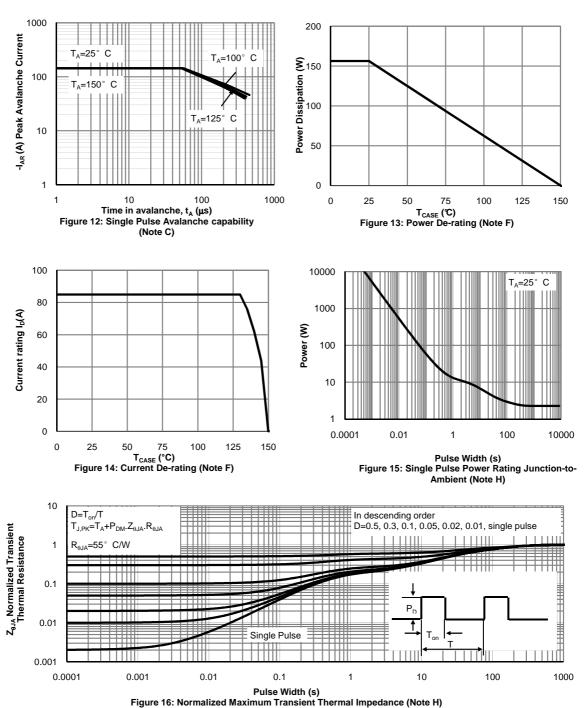
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

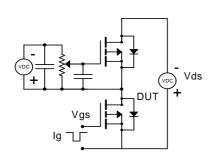


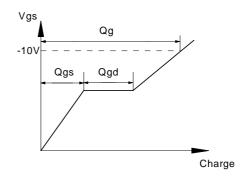
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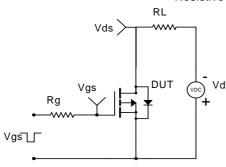


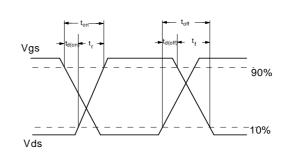
Gate Charge Test Circuit & Waveform



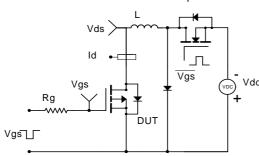


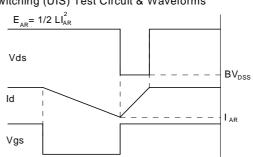
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

